



Integrated Device Technology, Inc.

256K x 32 CMOS STATIC RAM MODULE

**IDT7MP4045
IDT7MP4145**

- High density 1 megabyte static RAM module (IDT7MP4145 upgradeable to 4 megabyte, IDT7MP4120)
- Low profile 64 pin ZIP (Zig-zag In-line vertical Package) or 64 pin SIMM (Single In-line Memory Module) for IDT7MP4045 and 72 pin SIMM (Single In-line Memory Module) for IDT7MP4145
- Very fast access time: 15ns (max.)
- Surface mounted plastic components on an epoxy laminate (FR-4) substrate
- Single 5V ($\pm 10\%$) power supply
- Multiple GND pins and decoupling capacitors for maximum noise immunity
- Inputs/outputs directly TTL-compatible

PIN CONFIGURATION 7MP4045⁽¹⁾

PD0	2	1	GND	PD0 - GND
I/O0	4	3	PD1	PD1 - GND
I/O1	6	5	I/O8	
I/O2	8	7	I/O9	
I/O3	10	9	I/O10	
Vcc	12	11	I/O11	
A7	14	13	A0	
A8	16	15	A1	
A9	18	17	A2	
I/O4	20	19	I/O12	
I/O5	22	21	I/O13	
I/O6	24	23	I/O14	
I/O7	26	25	I/O15	
WE	28	27	GND	
A14	30	29	A15	
CS1	32	31	CS2	
ZIP, SIMM TOP VIEW				
CS3	34	33	CS4	
A16	36	35	A17	
GND	38	37	OE	
I/O16	40	39	I/O24	
I/O17	42	41	I/O25	
I/O18	44	43	I/O26	
I/O19	46	45	I/O27	
A10	48	47	A3	
A11	50	49	A4	
A12	52	51	A5	
A13	54	53	Vcc	
I/O20	56	55	A6	
I/O21	58	57	I/O28	
I/O22	60	59	I/O29	
I/O23	62	61	I/O30	
GND	64	63	I/O31	

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NOTE:

1. Pins 2 and 3 (PD0 and PD1) are read by the user to determine the density of the module. If PD0 reads GND and PD1 reads GND, then the module has a 256K depth.

DESCRIPTION:

The IDT7MP4045/4145 is a 256K x 32 static RAM module constructed on an epoxy laminate (FR-4) substrate using 8 256K x 4 static RAMs in plastic SOJ packages. Availability of four chip select lines (one for each group of two RAMs) provides byte access. The IDT7MP4045 is available with access time as fast as 10ns with minimal power consumption.

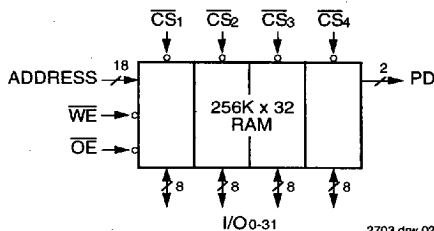
The IDT7MP4045 is packaged in a 64 pin FR-4 ZIP (Zig-zag In-line vertical Package) or a 64 pin SIMM (Single In-line Memory Module) where as the 7MP4145 is packaged in a 72 pin SIMM (Single In-line Memory Module). The 4045 ZIP configuration allows 64 pins to be placed on a package 3.65 inches long and 0.365 inches wide. The 7MP4045 ZIP is only 0.585 inches high, this low profile package is ideal for systems with minimum board spacing while the SIMM configuration allows use of edge mounted sockets to secure the module.

All inputs and outputs of the IDT7MP4045/4145 are TTL-compatible and operate from a single 5V supply. Full asynchronous circuitry requires no clocks or refresh for operation and provides equal access and cycle times for ease of use.

Identification pins are provided for applications in which different density versions of the module are used. In this way, the target system can read the respective levels of PD pins to determine a 256K depth.

The contact pins are plated with 100 micro-inches of nickel covered by 30 micro-inches minimum of selective gold.

FUNCTIONAL BLOCK DIAGRAM



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PIN NAMES

I/O0-31	Data Inputs/Outputs
A0-17	Addresses
CS1-4	Chip Selects
WE	Write Enable
OE	Output Enable
PD0-1	Depth Identification
Vcc	Power
GND	Ground
NC	No Connect

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COMMERCIAL TEMPERATURE RANGE

DECEMBER 1995

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CAPACITANCE (TA = +25°C, F = 1.0MHz)

Symbol	Parameter ⁽¹⁾	Conditions	Max.	Unit
CIN(C)	Input Capacitance (CS)	V(IN) = 0V	20	pF
CIN(A)	Input Capacitance (Address & Control)	V(IN) = 0V	70	pF
CIO	I/O Capacitance	V(OUT) = 0V	12	pF

NOTE: 2703 tbi 02
1. This parameter is guaranteed by design but not tested.

RECOMMENDED DC OPERATING CONDITIONS

Symbol	Parameter	Min.	Typ.	Max.	Unit
VCC	Supply Voltage	4.5	5.0	5.5	V
GND	Supply Voltage	0	0	0	V
VIH	Input High Voltage	2.2	—	6.0	V
VIL	Input Low Voltage	-0.5 ⁽¹⁾	—	0.8	V

NOTE: 2703 tbi 03
1. VIL (min) = -1.5V for pulse width less than 10ns.

RECOMMENDED OPERATING TEMPERATURE AND SUPPLY VOLTAGE

Grade	Ambient Temperature	GND	VCC
Commercial	0°C to +70°C	0V	5.0V ± 10%

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TRUTH TABLE

Mode	CS	OE	WE	Output	Power
Standby	H	X	X	High-Z	Standby
Read	L	L	H	DATAOUT	Active
Write	L	X	L	DATAIN	Active
Read	L	H	H	High-Z	Active

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ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Rating	Value	Unit
VTERR	Terminal Voltage with Respect to GND	-0.5 to +7.0	V
TA	Operating Temperature	0 to +70	°C
TBIAS	Temperature Under Bias	-10 to +85	°C
TSTG	Storage Temperature	-55 to +125	°C
IOUT	DC Output Current	50	mA

NOTE: 2703 tbi 06
1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

PIN CONFIGURATION 7MP4145⁽¹⁾

NC	2	1	NC	PD0 - GND
PD3	4	3	PD2	PD1 - GND
PD0	6	5	GND	PD2 - OPEN
I/O0	8	7	PD1	PD3 - OPEN
I/O1	10	9	I/O8	
I/O2	12	11	I/O9	
I/O3	14	13	I/O10	
VCC	16	15	I/O11	
A7	18	17	A0	
A8	20	19	A1	
A9	22	21	A2	
I/O4	24	23	I/O12	
I/O5	26	25	I/O13	
I/O6	28	27	I/O14	
I/O7	30	29	I/O15	
WE	32	31	GND	
A14	34	33	A15	
CS1	36	35	CS2	
CS3	38	37	CS4	
A16	40	39	A17	
GND	42	41	OE	
I/O16	44	43	I/O24	
I/O17	46	45	I/O25	
I/O18	48	47	I/O26	
I/O19	50	49	I/O27	
A10	52	51	A3	
A11	54	53	A4	
A12	56	55	A5	
A13	58	57	VCC	
I/O20	60	59	A6	
I/O21	62	61	I/O28	
I/O22	64	63	I/O29	
I/O23	66	65	I/O30	
GND	68	67	I/O31	
NC	70	69	NC	
NC	72	71	NC	

**SIMM
TOP VIEW**

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NOTE:

- Pins 3,4,6, and 7 (PD0-3) are read by the user to determine the density of the module. If PD0, PD1 read GND and PD2, PD3 read OPEN, then the module has a 256K depth.

DC ELECTRICAL CHARACTERISTICS

(VCC = 5.0V ±10%, TA = 0°C to +70°C)

Symbol	Parameter	Test Conditions	Min.	Max.	Unit
II _L	Input Leakage (Address and Control)	V _{CC} = Max.; V _{IN} = GND to V _{CC}	—	80	μA
II _L	Input Leakage (Data)	V _{CC} = Max.; V _{IN} = GND to V _{CC}	—	10	μA
II _O	Output Leakage	V _{CC} = Max.; $\overline{CS}$ = V _{IH} , V _{OUT} = GND to V _{CC}	—	10	μA
V _{OL}	Output LOW	V _{CC} = Min., I _{OL} = 8mA	—	0.4	V
V _{OH}	Output HIGH	V _{CC} = Min., I _{OH} = -4mA	2.4	—	V

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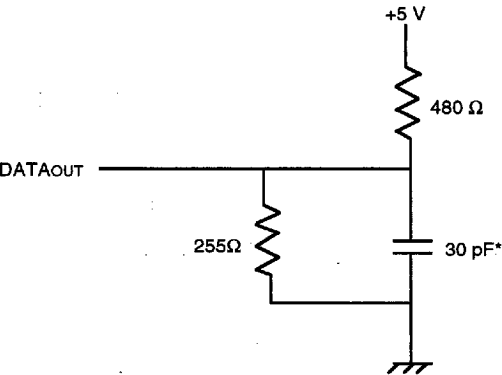
Symbol	Parameter	Test Conditions	Max.	Unit
I _{CC}	Dynamic Operating Current	f = f _{MAX} ; $\overline{CS}$ = V _{IL} V _{CC} = Max.; Output Open	1360	mA
I _{SB}	Standby Supply Current	$\overline{CS} \geq V_{IH}$, V _{CC} = Max. Outputs Open, f = f _{MAX}	480	mA
I _{SB1}	Full Standby Supply Current	$\overline{CS} \geq V_{CC} - 0.2V$; f = 0 V _{IN} > V _{CC} - 0.2V or < 0.2V	120	mA

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AC TEST CONDITIONS

Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	5ns
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load	See Figures 1-4

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*Includes scope and jig.
Figure 1. Output Load

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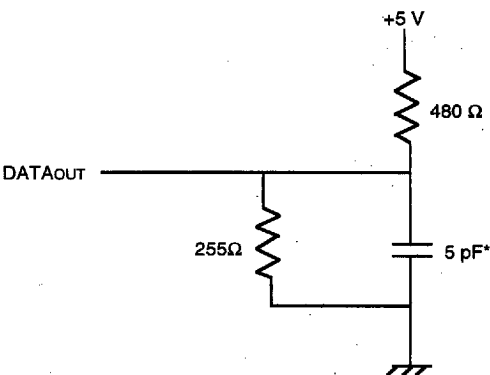


Figure 2. Output Load
(for tOLZ, tOHZ, tCHZ, tCLZ, tWHZ, tOW)

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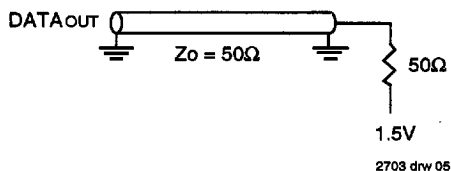


Figure 3. Alternate Output Load

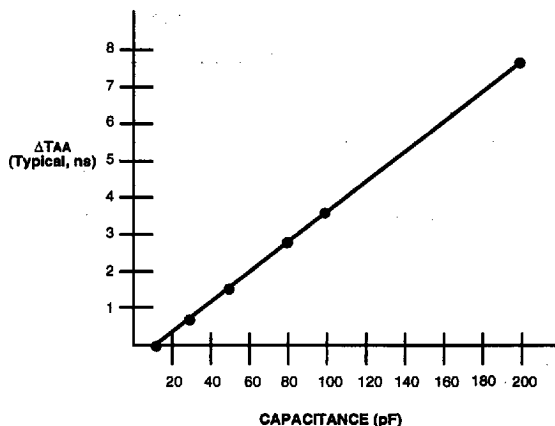


Figure 4. Alternate Lumped Capacitive Load, Typical Derating

AC ELECTRICAL CHARACTERISTICS

(VCC = 5V ±10%, TA = 0°C to +70°C)

Symbol	Parameter	7MP4045SxxZ, 7MP4045/4145SxxM						Unit
		-15		-20		-25		
		Min.	Max.	Min.	Max.	Min.	Max.	
Read Cycle								
t _{RC}	Read Cycle Time	15	—	20	—	25	—	ns
t _{AA}	Address Access Time	—	15	—	20	—	25	ns
t _{ACS}	Chip Select Access Time	—	15	—	20	—	25	ns
t _{CLZ} ⁽¹⁾	Chip Select to Output in Low-Z	3	—	5	—	5	—	ns
t _{OE}	Output Enable to Output Valid	—	8	—	10	—	12	ns
t _{OLZ} ⁽¹⁾	Output Enable to Output in Low-Z	0	—	0	—	0	—	ns
t _{CHZ} ⁽¹⁾	Chip Deselect to Output in High-Z	—	8	—	10	—	12	ns
t _{OHZ} ⁽¹⁾	Output Disable to Output in High-Z	—	8	—	10	—	10	ns
t _{OH}	Output Hold from Address Change	3	—	3	—	3	—	ns
t _{PU} ⁽¹⁾	Chip Select to Power-Up Time	0	—	0	—	0	—	ns
t _{PD} ⁽¹⁾	Chip Deselect to Power-Down Time	—	15	—	20	—	25	ns
Write Cycle								
t _{WC}	Write Cycle Time	15	—	20	—	25	—	ns
t _{CW}	Chip Select to End-of-Write	12	—	15	—	20	—	ns
t _{AW}	Address Valid to End-of-Write	12	—	15	—	20	—	ns
t _{AS}	Address Set-up Time	0	—	0	—	0	—	ns
t _{WP}	Write Pulse Width	12	—	15	—	20	—	ns
t _{WR}	Write Recovery Time	0	—	0	—	0	—	ns
t _{WHZ} ⁽¹⁾	Write Enable to Output in High-Z	—	8	—	13	—	15	ns
t _{DW}	Data to Write Time Overlap	10	—	12	—	15	—	ns
t _{DH}	Data Hold from Write Time	0	—	0	—	0	—	ns
t _{OW} ⁽¹⁾	Output Active from End-of-Write	0	—	0	—	0	—	ns

NOTE:

1. This parameter is guaranteed by design but not tested.

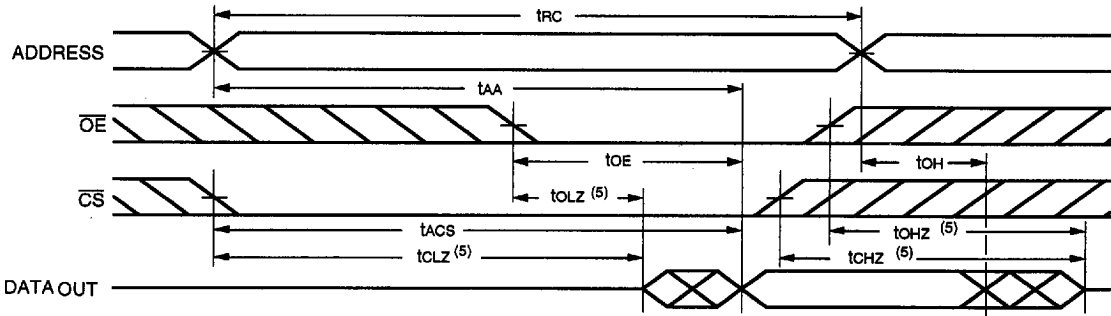
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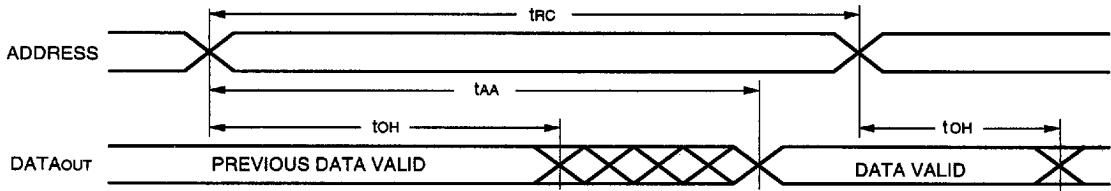
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TIMING WAVEFORM OF READ CYCLE NO. 1⁽¹⁾



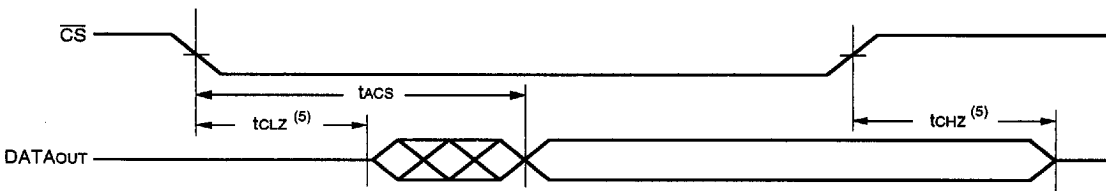
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TIMING WAVEFORM OF READ CYCLE NO. 2^(1,2,4)



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TIMING WAVEFORM OF READ CYCLE NO. 3^(1,3,4)

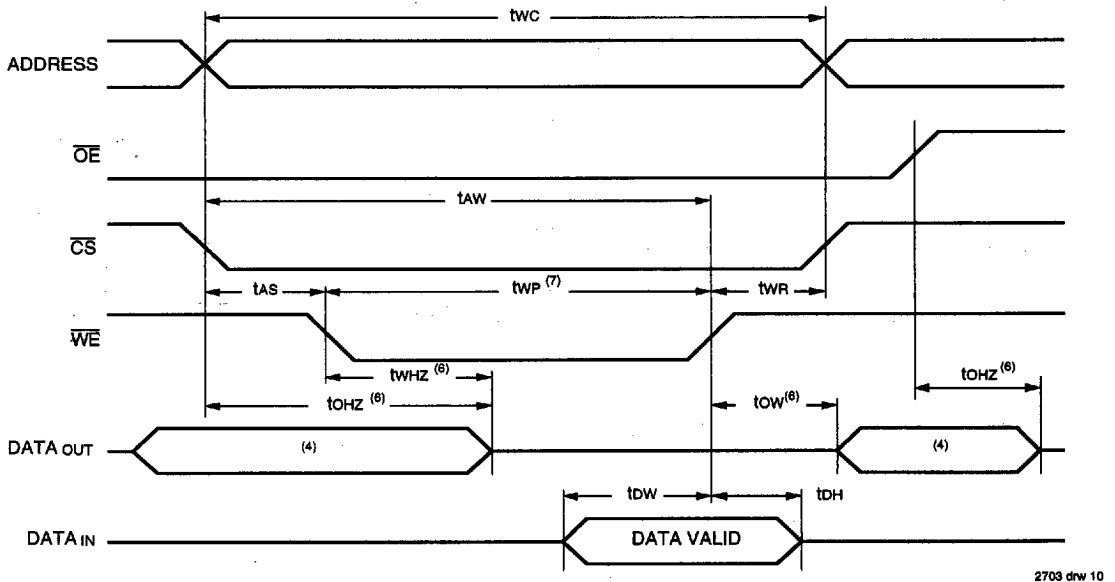


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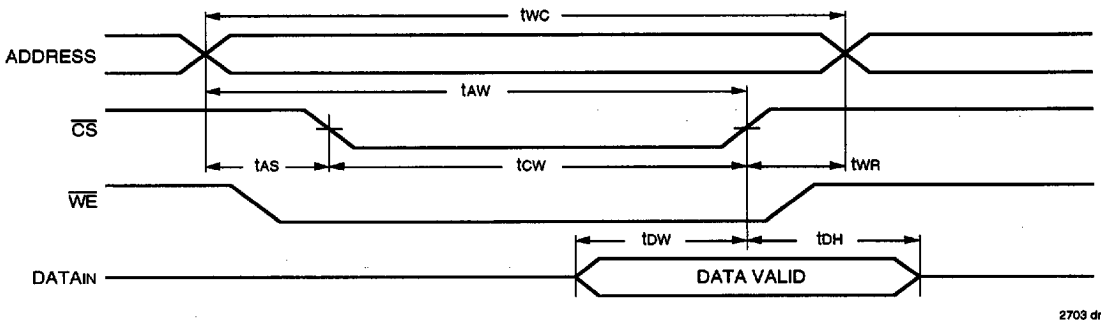
NOTES:

1. $\overline{WE}$ is HIGH for Read Cycle.
2. Device is continuously selected. $\overline{CS} = V_{IL}$.
3. Address valid prior to or coincident with $\overline{CS}$ transition LOW.
4. $\overline{OE} = V_{IL}$.
5. Transition is measured $\pm 200\text{mV}$ from steady state. This parameter is guaranteed by design, but not tested.

TIMING WAVEFORM OF WRITE CYCLE NO. 1 ($\overline{WE}$ CONTROLLED) (1, 2, 3, 7)



TIMING WAVEFORM OF WRITE CYCLE NO. 2 ($\overline{CS}$ CONTROLLED) (1, 2, 3, 5)

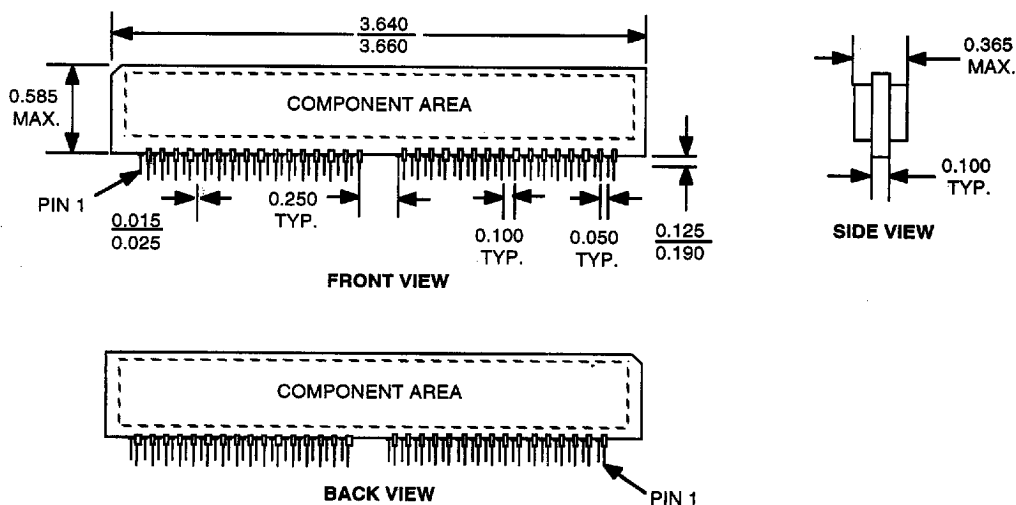


NOTES:

1. $\overline{WE}$ or $\overline{CS}$ must be HIGH during all address transitions.
2. A write occurs during the overlap (t_{wp}) of a LOW $\overline{CS}$ and a LOW $\overline{WE}$.
3. t_{wr} is measured from the earlier of $\overline{CS}$ or $\overline{WE}$ going HIGH to the end of write cycle.
4. During this period, I/O pins are in the output state, and input signals must not be applied.
5. If the $\overline{CS}$ LOW transition occurs simultaneously with or after the $\overline{WE}$ LOW transition, the outputs remain in a high-impedance state.
6. Transition is measured $\pm 200\text{mV}$ from steady state with a 5pF load (including scope and jig). This parameter is guaranteed by design, but not tested.
7. If $\overline{OE}$ is LOW during a $\overline{WE}$ controlled write cycle, the write pulse width must be the larger of t_{wp} or ($t_{whz} + t_{ow}$) to allow the I/O drivers to turn off and data to be placed on the bus for the required t_{ow} . If $\overline{OE}$ is HIGH during a $\overline{WE}$ controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified t_{wp} .

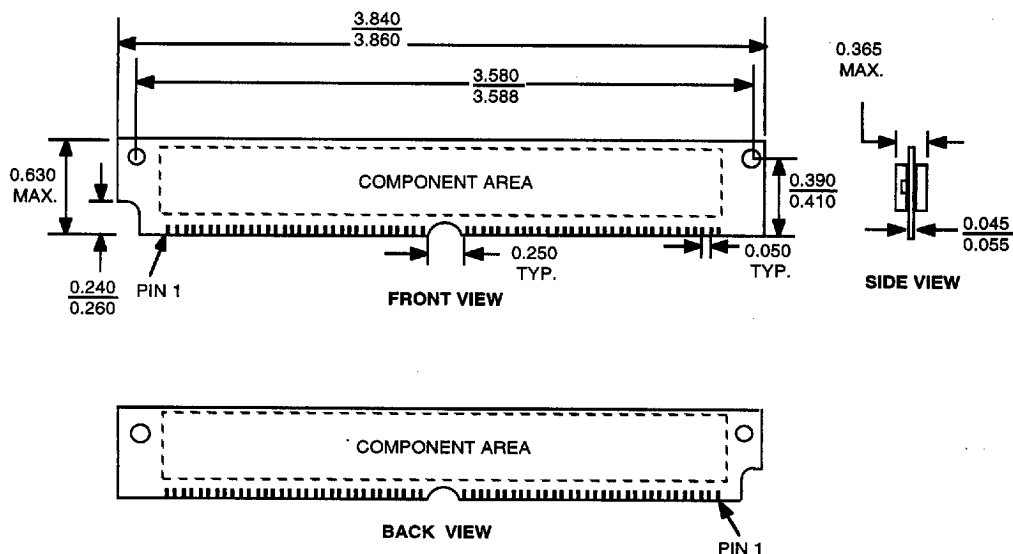
PACKAGE DIMENSIONS

7MP4045 ZIP VERSION



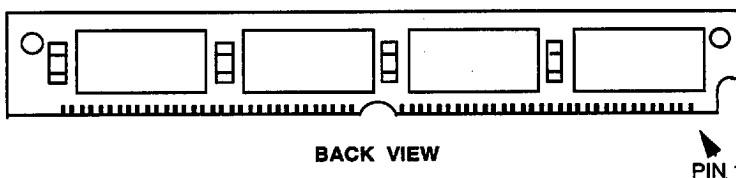
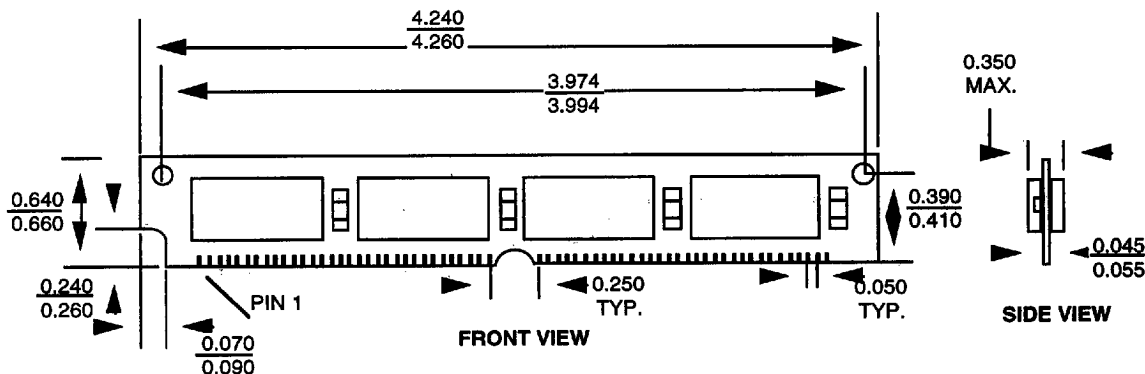
7MP4045 SIMM VERSION

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2703 drw 13

7MP4145 SIMM VERSION



2703 drw 16

ORDERING INFORMATION

IDT	XXXXX	X	X	X	X	
	Device Type	Power	Speed	Package	Process/ Temperature Range	
					Blank	Commercial (0°C to +70°C)
					Z	FR-4 ZIP (Zig-Zag In-line vertical Package)
					M	FR-4 SIMM (Single In-line Memory Module)
					10	} Speed in Nanoseconds
					12	
					15	
					20	
					25	
					S	Standard Power
					SA	Standard Power (Alternate)
					7MP4045	256K x 32 Static RAM Module

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